



# SIGC06T120CS

## IGBT Chip in NPT-technology

#### FEATURES:

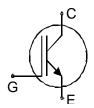
- 1200V NPT technology
- 180µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

## This chip is used for:

• SGP02N120

## Applications:

• drives, SMPS, resonant applications



Chip Type	V <sub>CE</sub>	<b>I</b> Cn	Die Size	Package	Ordering Code
SIGC06T120CS	1200V	2A	2.45 x 2.25 mm <sup>2</sup>	sawn on foil	Q67050-A4115- A001

## **MECHANICAL PARAMETER:**

Raster size	2.45 x 2.25				
Area total / active	5.512 / 2.5				
Emitter pad size	1.03x1.29				
Gate pad size	0.42x0.56				
Thickness	180	μm			
Wafer size	150	mm			
Flat position	0	deg			
Max.possible chips per wafer	2794 pcs				
Passivation frontside	Photoimide				
Emitter metalization	3200 nm Al Si 1%				
Collector metalization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500µm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, Tj=25 °C	V <sub>CE</sub>	1200	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	6	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55 +150	°C

<sup>1)</sup> depending on thermal properties of assembly

**STATIC CHARACTERISTICS** (tested on chip),  $T_i=25$  °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0V , I <sub>C</sub> =300 $\mu$ A	1200			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =2A	2.5	3.1	3.6	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_C=90\mu A$ , $V_{GE}=V_{CE}$	3.0	4.0	5.0	
Zero gate voltage collector current	I <sub>CES</sub>	$V_{CE}$ =1200V , $V_{GE}$ =0V			0.2	μA
Gate-emitter leakage current	I <sub>GES</sub>	$V_{CE}$ =0V , $V_{GE}$ =20V			120	nA

## DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
Falameter	Symbol		min.	typ.	max.	
Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	205	250	pF
Output capacitance	Coss	$V_{GE}=0V$ ,	-	28	34	
Reverse transfer capacitance	Crss	f=1MHz	-	17	21	

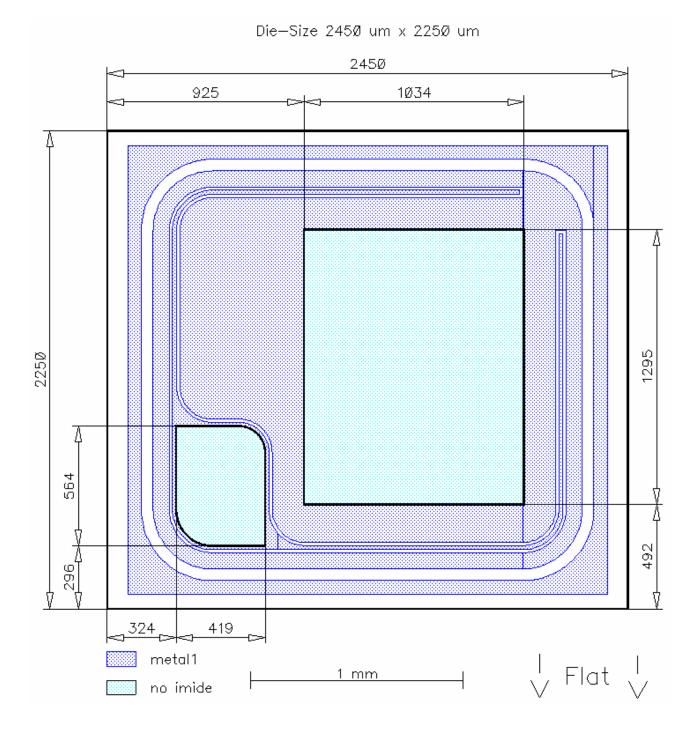
## **SWITCHING CHARACTERISTICS** (tested at component), Inductive Load:

Parameter	Symbol	Conditions*	Value			Unit
			min.	typ.	max.	Onic
Turn-on delay time	t <sub>d(on)</sub>	<i>T</i> <sub>j</sub> =25 °C <i>V</i> <sub>CC</sub> =800V, <i>I</i> <sub>C</sub> =2A	-	23	30	ns
Rise time	<i>t</i> r	<i>I</i> <sub>C</sub> =2A	-	16	21	
Turn-off delay time	$t_{d(off)}$	V <sub>GE</sub> =+15/0V, R <sub>G</sub> =91Ω	-	260	340	
Fall time	t <sub>f</sub>		-	61	80	

\* switching conditions different to LowLoss, Standard, IGBT3; under comparable switching conditions 40% faster than Standard. Values also influenced by parasitic L- and C- in measurement and package.



**CHIP DRAWING:** 





#### FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

SGP02N120

Package : TO220

#### Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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